


<b>Search Notes</b> 	<b>Application/Control No.</b> 1076884519767982	<b>Applicant(s)/Patent Under Reexamination</b> KOLOR ET AL.YUN ET AL.
	<b>Examiner</b> Khan, Ibrahim AKhan, Ibrahim A	<b>Art Unit</b> 26172617

SEARCHED			
Class	Subclass	Date	Examiner
370	280/281	01/24/2007	IAK
370370	331329	01/24/200702/12/2007	IAKIAK
455	452	2/2/2007	IAK

SEARCH NOTES		
Search Notes	Date	Examiner
EASTImage and keyword search in USPAT, US-PGPUB, DERWENT, EPO, IBM_TDB (see attached search strategy)	2/12/2007	IAK
Consulted Nick Corsaro (455 SPE)	2/12/2007	IAK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner